metal-organic papers

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Key indicators

Single-crystal X-ray study T = 297 KMean $\sigma(\text{C-C}) = 0.005 \text{ Å}$ R factor = 0.037 wR factor = 0.082 Data-to-parameter ratio = 13.1

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

{2,2'-[Ethane-1,2-diylbis(nitrilomethylidene)]diphenolato}cobalt(II)

The Co^{II} atom in the title compound, $[Co(C_{16}H_{14}N_2O_2)]$, has a square-planar coordination.

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Comment

Cobalt(II) Schiff base complexes have been extensively utilized as catalysts for the oxidation of organic molecules (Mukaiyama & Yamada, 1995; Fiammengo *et al.*, 2002). We have previously reported some lanthanide complexes with Schiff base ligands (Yuan *et al.*, 2004). The title mononuclear cobalt(II) complex, (I), is a further contribution in this area. The Co^{II} atom is four-coordinate, chelated by two O and two N atoms in a square-planar geometry (Fig. 1).



Experimental

Red crystals of (I) were obtained by slow evaporation of a solution in ethyl acetate–methanol (1:1 v/v) of a mixture (10 ml) of N,N'-bis(-salicylidene)-1,2-ethylenediamine (0.048 g, 0.2 mmol) and cobalt diacetate tetrahydrate (0.050 g, 0.2 mmol).



Figure 1

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Crystal data

 $\begin{bmatrix} Co(C_{16}H_{14}N_2O_2) \end{bmatrix} \\ M_r = 325.22 \\ Orthorhombic, Pbca \\ a = 7.471 (1) Å \\ b = 13.805 (2) Å \\ c = 26.096 (5) Å \\ V = 2691.5 (7) Å^3 \end{bmatrix}$

Data collection

Siemens P4 diffractometer ω scans Absorption correction: ψ scan (North *et al.*, 1968) $T_{min} = 0.514$, $T_{max} = 0.858$ 3059 measured reflections 2497 independent reflections

Refinement

-	
Refinement on F^2	$w = 1/[\sigma^2(F_o^2) + (0.035P)^2]$
$R[F^2 > 2\sigma(F^2)] = 0.037$	where $P = (F_0^2 + 2F_c^2)/3$
$wR(F^2) = 0.082$	$(\Delta/\sigma)_{\rm max} = 0.001$
S = 0.97	$\Delta \rho_{\rm max} = 0.31 \ {\rm e} \ {\rm \AA}^{-3}$
2497 reflections	$\Delta \rho_{\rm min} = -0.31 \text{ e } \text{\AA}^{-3}$
191 parameters	Extinction correction: SHELXL97
H-atom parameters constrained	Extinction coefficient: 0.0062 (3)

Z = 8

 $D_x = 1.605 \text{ Mg m}^{-3}$

0.58 \times 0.44 \times 0.12 mm

3 standard reflections

every 97 reflections

intensity decay: 2.0%

1605 reflections with $I > 2\sigma(I)$

Mo $K\alpha$ radiation

 $\mu = 1.28 \text{ mm}^{-1}$

T = 297 (2) K

Prism, red

 $R_{\rm int} = 0.013$

 $\theta_{\rm max} = 25.5^{\circ}$

Table 1

Selected bond lengths (Å).

Co-N2	1.838 (3)	Co-O1	1.845 (2)
Co-N1	1.844 (3)	Co-O2	1.850 (2)

All H atoms were positioned geometrically and refined as riding, with C-H = 0.93 Å and $U_{iso}(H) = 1.2U_{eq}(C)$.

Data collection: *XSCANS* (Siemens, 1994); cell refinement: *XSCANS*; data reduction: *SHELXTL* (Sheldrick, 1997*b*); program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997*a*); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997*a*); molecular graphics: *SHELXTL*; software used to prepare material for publication: *SHELXTL*.

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